




<b>Issue Classification</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/441,061	ENDL ET AL.	
	Examiner	Art Unit	
	F. Pierre VanderVegt	1644	

ISSUE CLASSIFICATION											
ORIGINAL					CROSS REFERENCE(S)						
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
530		402			530	325	325	326	327	328	403
INTERNATIONAL CLASSIFICATION											
C	0	7	K	14/74							
C	0	7	K	16/00							
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F. Pierre VanderVegt 12/12/05 (Assistant Examiner) (Date)					 <b>CHRISTINA CHAN</b> <b>SUPERVISORY PATENT EXAMINER</b> <b>TECHNOLOGY CENTER 1600</b> (Primary Examiner) (Date) 12/12/05					Total Claims Allowed: 17	
 (Legal Instruments Examiner) (Date) 12/13/05										O.G. Print Claim(s) 1	O.G. Print Fig. none

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant						<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
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